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US DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT

Patent Docket No.

989\_001DIV1

Serial No.

10/004,463

Applicant

James E. Moon et al.

Filing Date

November 02, 2001

Group

1746

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Exam. Initial		Document Number	Date	Name	Class	Sub Class	Filing Date
AG		4,764,244	08/16/1998	Chitty et al.			06/11/1985
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AO	Desai, Amish, et al., <i>A MEMS Electrospray Nozzle for Mass Spectroscopy</i> , 1997, pp. 927-930.
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AY	Xue, Gifeng, et al., <i>Multichannel Microchip Electrospray Mass Spectrometry</i> , 1997, pp. 426-430.
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	Applicant James E. Moon et al.		
	Filing Date	Group	

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Examiner	<i>Alta Ose</i> Date Considered <i>9/29/03</i>

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US DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT

Atty Docket No. 989\_001DIV1 (now 1153\_010 DIV1)
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Applicants James E. Moon et al.

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Examiner <i>Allen Olson</i>	Date Considered <i>9/29/03</i>	

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